

- Max  $r_{DS(on)} = 2.8 \text{ m}\Omega \text{ at } V_{GS} = 10 \text{ V}, I_D = 24 \text{ A}$
- Max  $r_{DS(on)} = 3.5 \text{ m}\Omega \text{ at } V_{GS} = 4.5 \text{ V}, I_D = 21 \text{ A}$
- Advanced package and silicon combination for low r<sub>DS(on)</sub> and high efficiency
- SyncFET Schottky Body Diode
- MSL1 robust package design
- 100% UIL tested
- RoHS Compliant

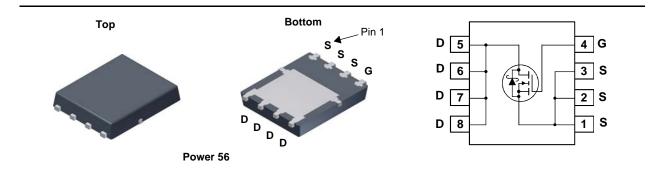


# **General Description**

The FDMS8025S has been designed to minimize losses in power conversion application. Advancements in both silicon and package technologies have been combined to offer the lowest  $r_{\text{DS}(\text{on})}$  while maintaining excellent switching performance.This device has the added benefit of an efficient monolithic Schottky body diode.

# **Applications**

- Synchronous Rectifier for DC/DC Converters
- Notebook Vcore/GPU low side switch
- Networking Point of Load low side switch
- Telecom secondary side rectification



## MOSFET Maximum Ratings T<sub>C</sub> = 25°C unless otherwise noted

Symbol	Parameter			Ratings	Units
V <sub>DS</sub>	Drain to Source Voltage			30	V
V <sub>GS</sub>	Gate to Source Voltage			±20	V
I <sub>D</sub>	Drain Current -Continuous (Package limited)	T <sub>C</sub> = 25°C		49	
	-Continuous (Silicon limited)	T <sub>C</sub> = 25°C		109	•
	-Continuous	$T_A = 25^{\circ}C$	(Note 1a)	24	Α
	-Pulsed	100			
E <sub>AS</sub>	Single Pulse Avalanche Energy		(Note 3)	66	mJ
P <sub>D</sub>	Power Dissipation	T <sub>C</sub> = 25°C		50	14/
	Power Dissipation	$T_A = 25^{\circ}C$	(Note 1a)	2.5	W
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Junction Temperature Range			-55 to +150	°C

### **Thermal Characteristics**

$R_{ ext{ heta}JC}$	Thermal Resistance, Junction to Case	2.5	°C/W
$R_{\thetaJA}$	Thermal Resistance, Junction to Ambient (Note 1	a) 50	0/11

### **Package Marking and Ordering Information**

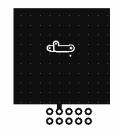
Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDMS8025S	FDMS8025S	Power 56	13 "	12 mm	3000 units

October 2014

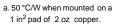
Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Chara	octeristics					
BV <sub>DSS</sub>	Drain to Source Breakdown Voltage	I <sub>D</sub> = 1 mA, V <sub>GS</sub> = 0 V	30			V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	$I_D = 10 \text{ mA}$ , referenced to 25°C		19		mV/°C
IDSS	Zero Gate Voltage Drain Current	$V_{DS} = 24 V, V_{GS} = 0 V$			500	μA
I <sub>GSS</sub>	Gate to Source Leakage Current, Forward	$V_{GS} = 20 V, V_{DS} = 0 V$			100	nA
On Chara	cteristics					
V <sub>GS(th)</sub>	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = 1 \text{ mA}$	1.2	1.7	3.0	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	$I_D = 10$ mA, referenced to 25°C		-5		mV/°C
r <sub>DS(on)</sub>	Static Drain to Source On Resistance	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 24 A		2.2	2.8	
		$V_{GS} = 4.5 V, I_D = 21 A$		3.0	3.5	mΩ
		$V_{GS} = 10 V, I_D = 24 A, T_J = 125^{\circ}C$		3.1	4.0	
9 <sub>FS</sub>	Forward Transconductance	$V_{DS} = 5 V, I_{D} = 24 A$		145		S
Dynamic	Characteristics					
C <sub>iss</sub>	Input Capacitance			2255	3000	pF
C <sub>oss</sub>	Output Capacitance	V <sub>DS</sub> = 15 V, V <sub>GS</sub> = 0 V, f = 1MHz		815	1085	pF
C <sub>rss</sub>	Reverse Transfer Capacitance			85	125	pF
R <sub>g</sub>	Gate Resistance			1.0	2.5	Ω
Switching	g Characteristics					
t <sub>d(on)</sub>	Turn-On Delay Time			11	19	ns
t <sub>r</sub>	Rise Time	V <sub>DD</sub> = 15 V, I <sub>D</sub> = 24 A,		4.5	10	ns
t <sub>d(off)</sub>	Turn-Off Delay Time	$V_{GS} = 10 \text{ V}, \text{ R}_{GEN} = 6 \Omega$		29	46	ns
t <sub>f</sub>	Fall Time	1		3.7	10	ns
Qg	Total Gate Charge	$V_{GS} = 0$ V to 10 V		34	47	nC
Qg	Total Gate Charge	$V_{GS} = 0 V \text{ to } 4.5 V V_{DD} = 15 V,$		16	23	nC
Q <sub>gs</sub>	Gate to Source Charge	I <sub>D</sub> = 24 A		5.9		nC
Q <sub>gd</sub>	Gate to Drain "Miller" Charge			4.6		nC
Drain-Sou	urce Diode Characteristics					
		$V_{GS} = 0 V, I_S = 2 A$ (Note 2)		0.62	0.8	
V <sub>SD</sub>	Source-Drain Diode Forward Voltage	$V_{GS} = 0 V, I_S = 24 A$ (Note 2)		0.8	1.2	V
t <sub>rr</sub>	Reverse Recovery Time	-I <sub>F</sub> = 24 A, di/dt = 300 A/μs		26	42	ns

$Q_{rr}$	
Notes	

Notes: 1. R<sub>0JA</sub> is determined with the device mounted on a 1 in<sup>2</sup> pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. R<sub>0JC</sub> is guaranteed by design while R<sub>0CA</sub> is determined by the user's board design.



Reverse Recovery Charge





b. 125 °C/W when mounted on a minimum pad of 2 oz copper.

27

44

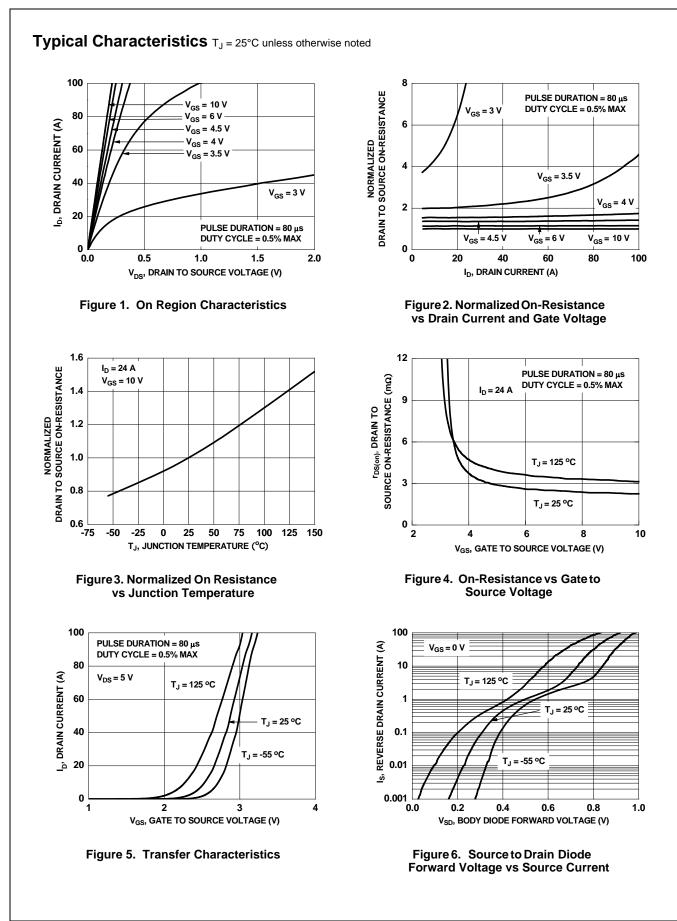
nC



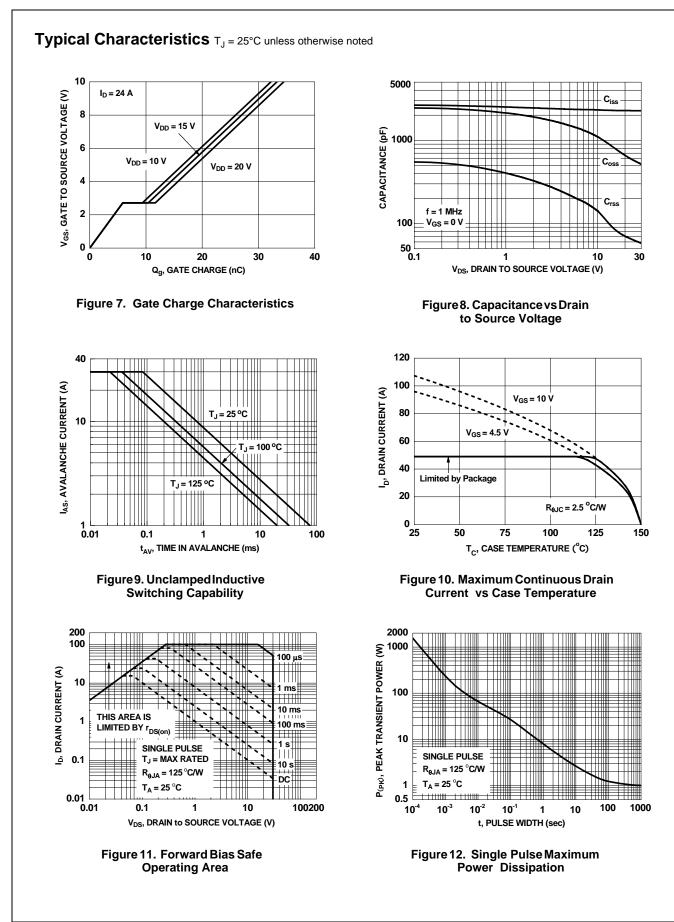
2. Pulse Test: Pulse Width < 300  $\mu s,$  Duty cycle < 2.0%.

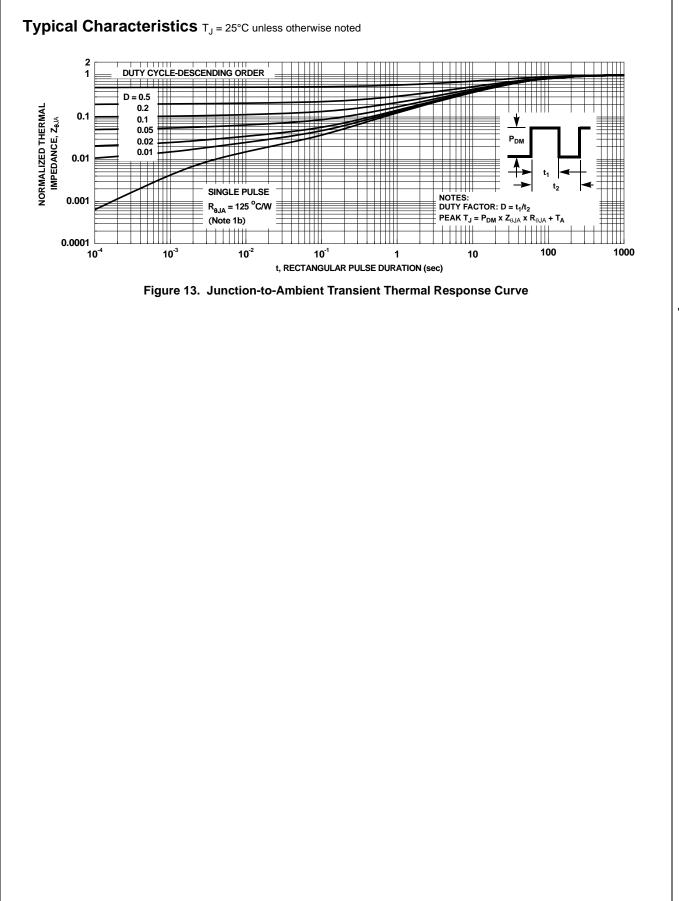
3.  $E_{AS}$  of 66 mJ is based on starting  $T_J$  = 25 °C, L = 0.3 mH,  $I_{AS}$  = 21 A,  $V_{DD}$  = 27 V,  $V_{GS}$  = 10 V.

4. As an N-ch device, the negative Vgs rating is for low duty cycle pulse occurrence only. No continuous rating is implied.









# FDMS8025S N-Channel PowerTrench<sup>®</sup> SyncFET<sup>TM</sup>

# Typical Characteristics (continued)

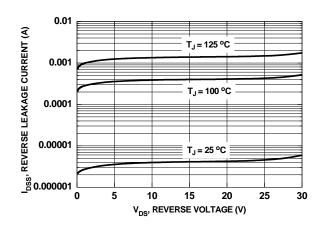
### SyncFET Schottky body diode Characteristics

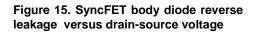
Fairchild's SyncFET process embeds a Schottky diode in parallel with PowerTrench MOSFET. This diode exhibits similar characteristics to a discrete external Schottky diode in parallel with a MOSFET. Figure 14 shows the reverse recovery characteristic of the FDMS8025S.

25 20 15 CURRENT (A) 10 di/dt = 300 A/µs 5 0 -5 0 50 100 200 250 150 TIME (ns)

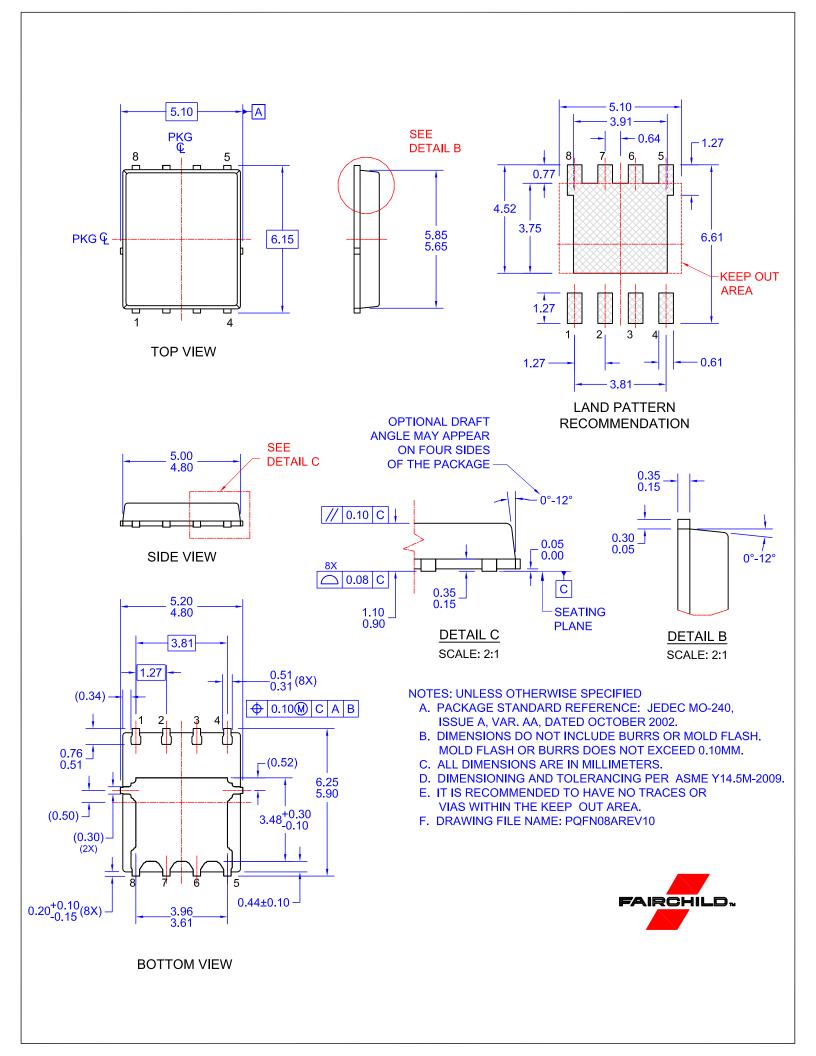
Figure 14. FDMS8025S SyncFET body diode reverse recovery characteristic

Schottky barrier diodes exhibit significant leakage at high temperature and high reverse voltage. This will increase the power in the device.





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